AN14417 Using the SEMC SRAM WAIT feature on i.MX RT1180 Rev. 2.0 — 10 March 2025

Application note

Document information

Information	Content
Keywords	AN14417, SEMC SRAM wait feature, RT1180, i.MX RT1180, smart external memory controller, SEMC, SRAM, WAIT
Abstract	This application note introduces the i.MX RT1180 SEMC SRAM WAIT feature, the background for necessity of the WAIT feature and how it works on i.MX RT1180.



1 Overview

This application note describes the i.MX RT1180 smart external memory controller (SEMC) static randomaccess memory (SRAM) WAIT feature. The document also provides the background for the necessity of the WAIT feature and how it works on i.MX RT1180. An i.MX RT1170 EVK board helps simulate a device and generate the WAIT signal for evaluation.

2 Importance of the WAIT signal

For some device, each access cycle is not constant and you must not access it by a fixed configuration. In such case, use the WAIT/BUSY/RDY signal to get the maximum bandwidth. For example, a device sometimes needs 80 ns to end the access cycle. Whereas sometimes a device needs 200 ns to end the access cycle. By fixed configuration, one must set the wait time as the maximum access time, which is 200 ns access cycle. In such a case, 120 ns gets wasted for a short period access cycle of 80 ns.

Note: In different scenario, WAIT is referred to as BUSY or READY/RDY.

The picture below is an example that the negating WAIT pin terminates the access cycle.

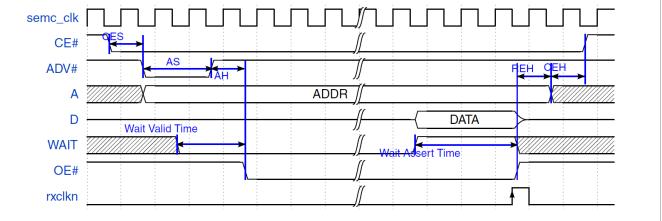


Figure 1. Example of the WAIT pin use case

3 Design of the WAIT feature on i.MX RT1180

This section describes the WAIT feature-related bit and the configuration of the modes.

3.1 WAIT feature-related register bit

The WAIT feature-related register bit includes:

- WAITEN: Bit 2 in SRAMC0/4
- WAITSP: Bit 3 in SRAMC0/4
- WAIT_TIME: Bit 16 in SRAMC0/4

Note:

- Device 0/CSX 0 uses SRAMC0
- Device 1-3/CSX 1-3 uses SRAMC4

3.2 Configuration for two different modes

The following table lists the two modes used in the application.

Table 1. Configuration of mode	s
--------------------------------	---

	WAITEN	WAITSP	WAIT_TIME	Comment
Mode 1	1	1	0	If there is WAIT asserted in every access cycle, use this configuration mode.
Mode 2	1	1	1	If the device sometimes asserts WAIT, and sometimes does not assert WAIT, use this configuration mode.

- For Mode 1: SEMC checks the WAIT rising edge. When WAIT rising edge appears, SEMC immediately terminates the current access cycle.
- For Mode 2: SEMC at first counts the REL/WEL down. When a REL/WEL timeout happens, SEMC checks the WAIT line status. If WAIT asserts at this moment, SEMC waits until WAIT negates. If WAIT does not assert at the moment, SEMC terminates the current access cycle.

4 Evaluate SEMC WAIT feature on i.MX RT1180 EVK

This section describes the steps to <u>route signals out from i.MX RT1180</u> and <u>simulate device behavior</u>. The section also describes the <u>test cases and result for mode 1 and mode 2</u>.

4.1 How to route signals out from i.MX RT1180 EVK

Due to hardware limitation, this application note shows only the basic WAIT feature behavior, instead of a fully and whole SRAM access with WAIT feature. At least four signals route out to evaluate the SEMC WAIT feature. The signals are CS, WAIT, OE, and WE.

The table below guides how to route the signals out from i.MX RT1180 EVK.

Table Il Reate eignale eat		
Signal	Mapping to SEMC	Watchpoint on i.MX RT1180 EVK
CS	SEMC_CSX0	R188
WAIT	SEMC_BA0	R168
OE	SEMC_A12	Pin36 of U16
WE	SEMC_A11	R167

Table 2. Route signals out from i.MX RT1180 EVK

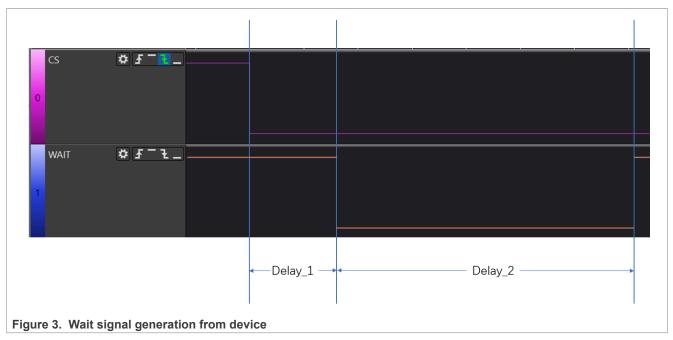
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4.2 How to simulate device behavior

To evaluate the wait feature in different conditions, we need a device for checking CS. Once CS is low, after Delay_1 it asserts WAIT. After Delay 2, it negates WAIT.

The command in the console enables the programming and specification of Delay 1 and Delay 2.



An i.MX RT1170 EVK board was used for the device test. The figure below shows the connection between the i.MX RT1180 EVK and i.MX RT1170 EVK boards.

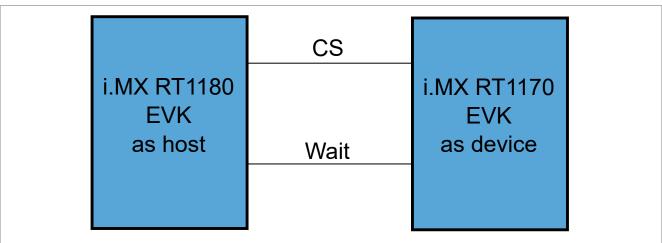


Figure 4. Connection between i.MX RT1180 EVK and i.MX RT1170 EVK

For i.MX RT1170 pin assignment, see the table below.

Table 3. I.MX R11170 pin a	assignment	
Signal	Pin assignment	Location on board
CS	GPIO_AD_11	J26 pin 4
WAIT	GPIO_AD_10	J26 pin 2
GND		J26 pin 1

For the location of the signals on the board, see the image below.



Figure 5. Location of CS/WAIT signal on board

4.3 Test cases and result

This section introduces some test cases to check the WAIT feature on the i.MX RT1180 EVK board.

The delay and wait_low value mentioned below is the parameter for void wait_simulate(int delay, int wait_low) and it is used to generate Delay_1 and Delay_2 mentioned in Section 4.2. For more information on code, see Section 5.2.

4.3.1 Test cases for Mode 1

Test case 1: Read, WAIT for 16 ns (delay=0, wait low=0).

Result:



Figure 6. Mode 1, Read, WAIT for 16 ns

Test case 2: Read, WAIT for 104 ns (delay=0, wait_low=10). The following image illustrates that the WAIT signal extends the access cycle.

Result:

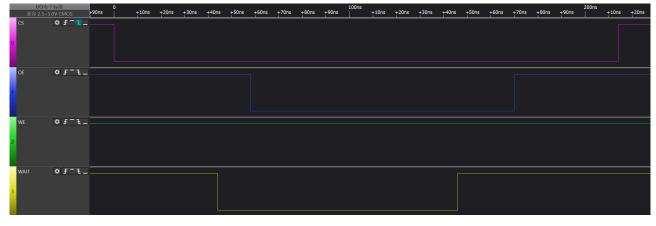


Figure 7. Mode 1, Read, WAIT for 104 ns

Test case 3: Write, WAIT for 16 ns (delay=0, wait_low=0).

Result:



Figure 8. Mode 1, Write, WAIT for 16 ns

Test case 4: Write, WAIT for 104 ns (delay=0, wait_low=10). The following image illustrates that the WAIT signal extends the access cycle.

Result:

	电平标准 ~5.0V CMOS	0 -90ns	+10ns	+20ns	+30ns	+40ns	+50ns	+60ns	+70ns	+80ns	+90ns	100ns	+10ns	+20ns	+30ns	+40ns	+50ns	+60ns	+70ns	+80ns	+90ns	200ns	+10ns	+20ns	+30ns
cs 0	\$ _																								
OE 1	¢∮-1_																								
2 WE	¢∮-1_																								
WAIT	\$F-f_																								
Figure	9 Mod	a 1 Wi	rito \	רו אי	for	104	ne																		

Figure 9. Mode 1, Write, WAIT for 104 ns

4.3.2 Test cases for Mode 2

Test case 1: Read, no WAIT (delay=20, wait_low=0). When REL timeout, WAIT is not asserted, then the SEMC begins to terminate the current access cycle.

Result:



Figure 10. Read, no WAIT

Test case 2: Read, with WAIT (delay=0, wait_low=10). When REL timeout, WAIT is asserted, then the SEMC terminates the current access cycle after WAIT negates.

Result:



Figure 11. Read, with WAIT

Test case 3: Write, no WAIT (delay=20, wait_low=0). When WEL timeout, WAIT is not asserted, then the SEMC begins to terminate the current access cycle.

Result:

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Test case 4: Write, with WAIT (delay=0, wait_low=10). When WEL timeout, WAIT is asserted, then the SEMC terminates the current access cycle after WAIT negates.

Result:

		1	-90ns	+10ns	+20ns	+30ns	+40ns	+50ns	+60ns	+70ns	+80ns	+90ns	100ns	+10ns	+20ns	+30ns	+40ns	+50ns	+60ns	+70ns	+80ns	+90ns	200ns	+10ns	+20ns	+30ns
	cs	¤ ₹ ¯∎_)																								
	OE 1	¢ ƒ [−] ₹_)																								
	WE 2	¢ ƒ [−] ₹_																								
	WAIT 3	¢ f [−] t_																								
F	igure	13. Wri	te, wi	th WA	IT																					

5 Key code

This section lists the key codes on the i.MX RT1180 EVK and i.MX RT1170 EVK boards.

5.1 Key code on i.MX RT1180

The test code is based on the SEMC driver example in the SDK.

Make sure to configure GPIO_EMC_B1_41 for SEMC_CSX00.

Also, BOARD_InitPins() must have the following code added to it.

```
IOMUXC_SetPinMux(IOMUXC_GPIO_EMC_B1_41_SEMC_CSX00, 0U);
IOMUXC_SetPinConfig(IOMUXC_GPIO_EMC_B1_41_SEMC_CSX00, 0x08U);
```

```
Semc sdram.c must have the following code applied to it.
```

```
/*
 * Copyright 2017-2020 NXP
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 */
#include "fsl_debug_console.h"
#include "fsl_device_registers.h"
#include "pin_mux.h"
#include "clock config.h"
#include "board.h"
#include "fsl semc.h"
#include "fsl cache.h"
* Definitions
 #define EXAMPLE SEMC
                             SEMC
#define EXAMPLE SEMC START ADDRESS (0x800000000)
#define EXAMPLE SEMC CLK FREQ CLOCK GetRootClockFreq(kCLOCK Root Semc)
* Code
 void APP ConfigMPU(void)
 {
    /* Disable code & system cache */
    XCACHE DisableCache (XCACHE PC);
    XCACHE DisableCache (XCACHE PS);
    /* Disable MPU */
    ARM MPU Disable();
    /* Region 9 setting: Memory with Normal type, not shareable, outer/inner
 write through */
   ARM MPU SetRegion (2U, ARM MPU RBAR (EXAMPLE SEMC START ADDRESS,
 ARM MPU SH OUTER, OU, 1U, OU), ARM MPU RLAR(0xDFFFFFFF, 1U));
    /* Enable MPU */
    ARM MPU Enable (MPU CTRL PRIVDEFENA Msk);
    /* Enable code & system cache */
    XCACHE EnableCache (XCACHE_PS);
    XCACHE EnableCache (XCACHE PC);
}
status t BOARD InitSEMC SRAM(void)
 {
    status t status;
    semc_config_t config;
    semc_sram_config_t sram_config;
    uint32_t clockFrq = EXAMPLE SEMC CLK FREQ;
   memset(&config, 0, sizeof(semc config t));
   memset(&sram config, 0, sizeof(sram config));
    /* Initialize SEMC. */
    SEMC GetDefaultConfig(&config);
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```

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```
config.dqsMode = kSEMC Loopbackdqspad; /* For more accurate timing. */
SEMC Init(SEMC, &config);
//SRAM config.
sram config.cePinMux = kSEMC MUXCSX0;
sram config.addr27 = kSEMC MORA27 NONE;
sram config.address = EXAMPLE SEMC START ADDRESS;
sram config.memsize kbytes = 1\overline{6};
sram config.addrPortWidth = 8;
sram config.addrMode = kSEMC AddrDataNonMux;
sram_config.burstLen = kSEMC_Nor_BurstLen1;
sram_config.portSize = kSEMC_PortSize8Bit;
sram config.syncMode = kSEMC AsyncMode;
sram config.waitEnable = true;
sram config.waitSample = true;
sram config.advLevelCtrl = kSEMC AdvHigh;
#define NS SET 20
#define NS_SET 20
sram_config.tCeSetup_Ns = NS_SET;
sram_config.tCeHold_Ns = NS_SET;
sram_config.tAddrSetup_Ns = NS_SET;
sram_config.tAddrHold_Ns = NS_SET;
sram_config.tWeLow_Ns = NS_SET;
sram_config.tReLow_Ns = NS_SET;
sram_config.tReHigh_Ns = NS_SET;
sram_config.tCeInterval_Ns = NS_SET;
// For async mode
sram config.tTurnAround Ns = NS SET;
sram config.tAddr2WriteHold Ns = NS SET;
PRINTF("semc clock = %d\r\n", clockFrq);
status = SEMC ConfigureSRAM(SEMC, &sram config, clockFrq);
// Enable Mode 2, mask this line to get Mode 1.
SEMC->SRAMCR0 |= 0x10000;
PRINTF("SEMC->SRAMCR0 = %x\r\n", SEMC->SRAMCR0);
PRINTF("SEMC->SRAMCR1 = %x\r\n", SEMC->SRAMCR1);
PRINTF("SEMC->SRAMCR2 = %x\r\n", SEMC->SRAMCR2);
PRINTF("SEMC->SRAMCR3 = %x\r\n", SEMC->SRAMCR3);
if (SEMC->SRAMCR0 & 0x10000)
{
     PRINTF("wait mode: mode 2.\r\n");
}
else
{
     PRINTF("wait mode: mode 1.\r\n");
}
return status;
```

Using the SEMC SRAM WAIT feature on i.MX RT1180

```
}
void test semc sram(void)
{
    char c;
    volatile uint8_t * p_8 = (volatile uint8_t *) EXAMPLE_SEMC_START_ADDRESS;
    volatile uint8 t r 8;
    while (1)
    {
        PRINTF("Press r for read and w for write. \r\n");
        c = GETCHAR();
        if(c == 'r')
        {
            PRINTF("read. \r\n");
            r 8 = *p 8;
        }
        if(c == 'w')
        {
            PRINTF("write. \r\n");
            *p 8 = r 8;
        }
    }
}
int main(void)
{
    BOARD ConfigMPU();
    BOARD InitPins();
    BOARD BootClockRUN();
    BOARD InitDebugConsole();
    APP ConfigMPU();
    PRINTF("\r\n SEMC SDRAM Example Start!\r\n");
    if (BOARD InitSEMC SRAM() != kStatus Success)
    {
        PRINTF("\r\n SEMC SDRAM Init Failed\r\n");
    }
    while (1)
    {
        test semc sram();
    }
}
```

5.2 Key code on i.MX RT1170

Apply the following code in the hello_world.c file of the hello world example in the SDK.

```
/*
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 */
```

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```
#include "fsl_device_registers.h"
#include "fsl_debug_console.h"
#include "pin_mux.h"
#include "clock config.h"
#include "board.h"
#include "fsl iomuxc.h"
#include <cr section macros.h>
* Code
#define WAIT HIGH CM7 GPIO3->DR SET = 0x200
#define WAIT_LOW CM7_GPI03->DR_CLEAR = 0x200
/*
delay: Control the time delay to assert WAIT after CS falling edge.
low: Control the WAIT low period length.
Typically used value:
Short wait period:
                                  delay = 0, wait low = 0, 16ns, 16ns
                                 delay = 0; wait low = 10; Ons, 104 ns
Long wait period :
No wait period during access cycle: delay = 10, wait low = 0; 104ns, 0ns,
*/
 RAMFUNC(SRAM ITC cm7) void wait simulate(int delay, int wait low)
{
   while(CM7 GPIO3->DR & 0x400)
     ;
   while(delay)
     delay--;
   WAIT LOW;
   while (wait low)
     wait low--;
   WAIT HIGH;
}
void set gpio3 fast(int pin index)
{
   if(pin index <= 16)
   {
       IOMUXC GPR->GPR42 |= (1UL << pin index);</pre>
   }
   else
   {
       IOMUXC GPR->GPR43 |= (1UL << (pin index-16));</pre>
   }
}
void rgpio init(void)
{
   gpio pin config t gpio config output = {kGPIO DigitalOutput, 0,
kGPIO NoIntmode};
   gpio pin config t gpio config input = {kGPIO DigitalInput, 0,
 kGPIO NoIntmode};
   CLOCK EnableClock(kCLOCK Iomuxc);
   // WAIT, GPIO AD 10 --> RGPIO 3, 9, RGPIO OUTPUT --> J26 pin 2
```

}

{

}

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```
IOMUXC SetPinMux(IOMUXC GPIO AD 10 GPIO MUX3 IO09,
                                                               OU);
    IOMUXC SetPinConfig(IOMUXC GPIO AD 10 GPIO MUX3 IO09, 0U);
    // CS, GPIO AD 11 --> GPIO 9, 10, RGPIO INPUT --> J26 pin 4
    IOMUXC SetPinMux(IOMUXC GPIO AD 11 GPIO MUX3 IO10,
                                                             OU);
    IOMUXC SetPinConfig(IOMUXC GPIO AD 11 GPIO MUX3 IO10, 0U);
    GPIO_PinInit(CM7_GPIO3, 9, &gpio_config_output);
GPIO_PinInit(CM7_GPIO3, 10, &gpio_config_input);
    set gpio3 fast(9);
    set gpio3 fast(10);
    // Set wait high.
    WAIT HIGH;
int main (void)
    int delay;
    int low;
    /* Init board hardware. */
    BOARD ConfigMPU();
    BOARD_InitPins();
    BOARD_BootClockRUN();
    BOARD InitDebugConsole();
    PRINTF("hello world.\r\n");
    rgpio init();
    while (1)
    {
       PRINTF("input delay and low: \r\n");
       SCANF("%d %d", &delay, &low);
       PRINTF("delay = %d, low = %d\r\n", delay, low);
       wait_simulate(delay, low);
    }
```

Note about the source code in the document 6

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7 Revision history

Table 4 summarizes revisions to this document.

 Table 4. Revision history

Document ID	Release date	Description
AN14417 v.2.0	10 March 2025	Replaced "SMEC" with "SEMC"
AN14417 v.1.0	18 February 2025	Initial public revision

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